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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/597,780	06/20/2000	Alessandro Cesare Callegari	YOR-9-2000-0010	6159
<div>7590 09/21/2009</div> <div>Paul D. Greeley, Esq. Ohlandt, Greeley, Ruggiero & Perle, L.L.P. One Landmark Square 10th Floor Stamford, CT 06901-2682</div>				
EXAMINER				
NGUYEN, HOAN C				
ART UNIT		PAPER NUMBER		
2871				
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09/21/2009		PAPER		

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

Office Action Summary**Application No.**

09/597,780

Applicant(s)

CALLEGARI ET AL.

Examiner

HOAN C. NGUYEN

Art Unit

2871

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --
Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 28 August 2009.
- 2a) ☐ This action is **FINAL**. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 9, 11-13, 37 and 41-44 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 9, 11-13, 37 and 41-44 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☐ The specification is objected to by the Examiner.
- 10) ☐ The drawing(s) filed on _____ is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) ☐ The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

Priority under 35 U.S.C. § 119

- 12) ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☐ All b) ☐ Some * c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
 2. ☐ Certified copies of the priority documents have been received in Application No. _____.
 3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

* See the attached detailed Office action for a list of the certified copies not received.

Attachment(s)

- 1) ☒ Notice of References Cited (PTO-892)
- 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)
- 3) ☐ Information Disclosure Statement(s) (PTO/SB/C)
- 4) ☐ Interview Summary (PTO-413)
Paper No(s)/Mail Date: _____
- 5) ☐ Notice of Informal Patent Application
- 6) ☐ Other: _____
- Paper No(s)/Mail Date: _____

DETAILED ACTION

Continued Examination Under 37 CFR 1.114

A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on 08/28/2009 has been entered.

Claims 1-8, 10, 14-36, 38-40 and 45 are cancelled. Claims 9, 11-13, 37, 41-44 are spending.

Claim Rejections - 35 USC § 112

The following is a quotation of the first paragraph of 35 U.S.C. 112:

The specification shall contain a written description of the invention, and of the manner and process of making and using it, in such full, clear, concise, and exact terms as to enable any person skilled in the art to which it pertains, or with which it is most nearly connected, to make and use the same and shall set forth the best mode contemplated by the inventor of carrying out his invention.

Claims 9, 11-13, 37, 41-44 are rejected under 35 U.S.C. 112, first paragraph, as failing to comply with the written description requirement. The claim(s) contains subject matter which was not described in the specification in such a way as to reasonably convey to one skilled in the relevant art that the inventor(s), at the time the application was filed, had possession of the claimed invention.

The claims 9 and 37 amends with new feature "a first transparent conductive layer disposed directly on said first surface of said bottom substrate", which is disclosed in the original specification.

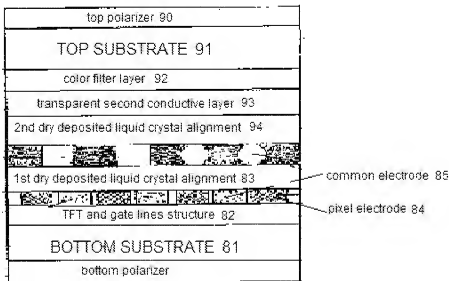
In the amendment filed on 07/22/2002, the original specification has been amended as following:

VERSION WITH MARKINGS TO SHOW CHANGES MADE IN THE SPECIFICATION:

Page 22, line 29 to page 23, line 12.

The in-plane switching mode liquid-crystal display comprises bottom polarizer 80, bottom substrate 81, **thin film transistor and bus line layer (detailed structure not shown but well known in the art) 82**, a top polarizer 90, a top substrate 91, a color filter layer 92, a second transparent conductive layer 93, **a plurality of common electrodes 84 disposed in the bottom substrate plane and a plurality of pixel electrodes 85 disposed in a staggering relationship therewith to form a comb-like structure**, a first dry deposited liquid-crystal alignment layer 83, a second dry deposited liquid-crystal alignment layer 94 being spaced adjacent to and facing the first dry deposited liquid-crystal alignment layer 83, a plurality of uniformly sized transparent or non-transparent spacers 96 distributed within the space, a liquid-crystal material 95 disposed in the space between the alignment layers. The spacers can be pearl or post shaped.

As Fig. 11 a shown:



Therefore, **the first transparent conductive layer**, that is pixel electrode 85 or common electrode 84, **is NOT** disposed directly on (contacted to) said first surface of said bottom substrate 81. Therefore, the amended feature in claims 9 and 37 considers as NEW SUBJECT MATTER.

Claims 11-13 and 41-44 are rejected since they depend on the infinitive claims.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

Claim 9, 11-13 and 37 are rejected under 35 U.S.C. 103(a) as being unpatentable over Oh et al. (US6665036B2) in view of **Togashi et al. (US 4345249 A)**, Kim et al. (US6111627A), Hiroshi (US5995186A), Callegari et al. (US6061114A).

In regard to claims 9 and 37, Oh et al. teach (Fig. 3A-B) a multi-domain liquid crystal display comprising

- a bottom substrate 210 having a first surface;
- a transparent conductive layer (data electrodes 208 and common electrode 209, thin film transistors and other display circuitry in bottom substrate to form the in-plane switching mode) disposed over said first surface of said bottom substrate.
- a top substrate 211 having a second surface;
- a color filter layer (color filter 229) disposed over a surface of the top substrate;

- a transparent conductive layer 118 disposed over said color filter;
- a first alignment layer 223a over said first transparent conductive layer
- a second alignment layer 223b made of over said second surface; said second alignment layer being spaced adjacent to and facing said first alignment layer;
- a liquid crystal material 230 disposed in the space therebetween;

wherein

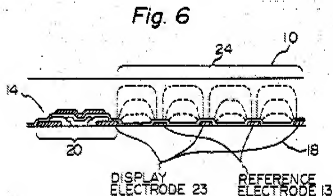
However, Oh et al. fail to disclose

(amended) a transparent conductive layer disposed directly on said first surface of said bottom substrate

- (a) a second transparent conductive layer disposed over the color filter;
- (b) a plurality of uniformly sized spacer 108 distributing within said space;
- (c) the alignment layers made of the dry deposited layers, which are made of material selected from the group consisting of hydrogenated diamond-like carbon, amorphous hydrogenated silicon, silicon carbide (SiC), silicon dioxide (SiO₂), glass, silicon nitride (Si₃N₄), alumina (Al₂O₃), cerium(IV) oxide (CeO₂), tin oxide (SnO₂), zinc titanate (ZnTiO₂) and a combination thereof as claim 12 cited;
- (d) each of said first alignment layer and said second alignment layer made of the dry deposited layers is divided into a plurality of pixels each having a boundary and at least two domains; wherein said domains are aligned by a mechanical mask; said dry deposited layers are exposed to at least a first ion beam bombardment and a second ion beam bombardment, where a ion beam and a ion beam use the same ion source, which is selected from the group consisting argon, nitrogen, oxygen and a mixture

thereof; and a direction of said first ion beam bombardment with respect to said dry deposited layer is different than a direction of said second ion beam bombardment with respect to said dry deposited layer.

Togashi et al. teach (Fig. 6) a transparent conductive layer (display electrode 23 and reference electrode 13) disposed directly on said first surface of said bottom substrate 18 for producing an electric field in a direction substantially parallel to the substrate plane to thereby act upon the liquid crystal (abstract).



Kim et al. teach (Fig. 4) (a) a second transparent conductive layer disposed over the color filter, which is formed on the surface of upper substrate; this second transparent conductive layer used for preventing electrostatics forming on the upper substrate (col. 3 lines 1-3). **Kim** also discloses the alignment layers 44 and 28.

Hiroshi teaches (Fig. 5) (b) a plurality of uniformly sized spacer 108 distributing within said space for supporting the thickness of liquid crystal layer (col. 5 lines 25-29).

Callegari et al. teach

(c) the alignment layers made of the dry deposited layers, which are made of material selected from the group consisting of hydrogenated diamond-like carbon, amorphous hydrogenated silicon, silicon carbide (SiC), silicon dioxide (SiO₂), glass, silicon nitride (Si₃N₄), alumina (Al₂O₃), cerium(IV) oxide (CeO₂), tin oxide (SnO₂), zinc titanate (ZnTiO₂) and a combination thereof for requiring fewer steps and less cost to manufacture (col. 3 lines 51-58);

(d) each of said first alignment layer and said second alignment layer made of the dry deposited layers is divided into a plurality of pixels each having a boundary and at least two domains; wherein each of said multi-domain, dry deposited layers is obtained by a mechanical mask 966; said dry deposited layers are exposed to at least a first particle (ion) beam and a second particle (ion) beam, where ion beam bombardment and a second ion beam bombardment use the same ion source, which is selected from the group consisting argon, nitrogen, oxygen and a mixture thereof; and a direction of said first ion beam bombardment with respect to said dry deposited layer is different than a direction of said second ion beam bombardment with respect to said dry deposited layer with the features of claim 11; thus deposited layers (alignment layers) are exposed to at least a first particle treatment and a second particle treatment to selectively align said domains in first direction (first fashion) and second direction (second fashion) respectively for resulting multidomain device so that attributing large view angle (col. 6 lines 19-31). **Callegari et al. also disclose mask with features etched into it can also be used to selectively align a local area, thus leading to the fabrication of domains of alignment** (col. 6 lines 24-27).

Therefore, it would have been obvious to one having ordinary skill in the art at the time the invention was made to further modify a multi-domain liquid crystal display as Oh et al. disclosed with a transparent conductive layer disposed directly on said first surface of said bottom substrate for producing an electric field in a direction substantially parallel to the substrate plane to thereby act upon the liquid crystal as **Togashi et al.** taught (abstract); (a) a second transparent conductive layer disposed over the color filter, which is formed on the surface of upper substrate; this second transparent conductive layer used for preventing electrostatics forming on the upper substrate (col. 3 lines 1-3) as taught by Kim et al.; (b) a plurality of uniformly sized spacer 108 distributing within said space for supporting the thickness of liquid crystal layer (col. 5 lines 25-29) as taught by Hiroshi; (c) the alignment layers made of the dry deposited layers, which are made of material selected from the group consisting of hydrogenated diamond-like carbon, amorphous hydrogenated silicon, silicon carbide (SiC), silicon dioxide (SiO₂), glass, silicon nitride (Si₃N₄), alumina (Al₂O₃), cerium(IV) oxide (CeO₂), tin oxide (SnO₂), zinc titanate (ZnTiO₂) and a combination thereof for requiring fewer steps and less cost to manufacture (col. 3 lines 51-58); (d) each of said first alignment layer and said second alignment layer made of the dry deposited layers is divided into a plurality of pixels each having a boundary and at least two domains; wherein each of said multi-domain, dry deposited layers is obtained by a mechanical mask 966; said dry deposited layers are exposed to at least a first particle (ion) beam and a second particle (ion) beam, where a first ion beam bombardment and a second ion beam bombardment use the same ion, which is selected from the group consisting

argon, nitrogen, oxygen and a mixture thereof; and a direction of said first particle beam treatment with respect to said dry deposited layer is different than a direction of said second particle treatment beam for resulting multidomain device so that attributing large view angle (col. 6 lines 19-31) with (1) non-contact alignment, (2) low energy, (3) large area uniform and parallel beam, (4) atomic beam being used to align both surfaces (col. 3 lines 25-40).

1. Claims 40-44 are rejected under 35 U.S.C. 103(a) as being unpatentable over Oh et al. (US6665036B2) in view of **Togashi et al. (US 4345249 A)**, Kim et al. (US6111627A), Hiroshi (US5995186A), and Callegari et al. (US6061114A) as applied to claims 9, 11-13, 37 and 40 in further view of Chaudhari et al. (US6124914A).

Oh et al. (US6665036B2) fail to disclose said first ion beam bombardment aligns first and second ones of the domains of at least one of said pixels in a first direction, and wherein said second ion beam bombardment aligns said first domain in a second direction as cited in claims 40-44.

Chaudhari et al. disclose the ion beam bombardment overwrites said first direction of said first domain with said second direction (col. 5 lines 2-26 and 58-63), wherein the first ion beam bombardment aligns first and second ones of the domains of at least one of said pixels in a first direction, and second ion beam bombardment aligns said first domain in a second direction; with mechanical mask, Fig. 9A-B shows the first ion beam bombardment aligns the alignment layer in one direction of surface 84 and the

second ion beam bombardment aligns said first domain in a second direction of surface 82 for patterning alignment direction on an alignment surface from more than one direction.

Therefore, it would have been obvious to one having ordinary skill in the art at the time the invention was made to further modify a multi-domain liquid crystal display as Oh et al. disclosed with the ion beam bombardment overwrites said first direction of said first domain with said second direction (col. 5 lines 2-26 and 58-63), wherein the first ion beam bombardment aligns first and second ones of the domains of at least one of said pixels in a first direction, and second ion beam bombardment aligns said first domain in a second direction; with mechanical mask, Fig. 9A-B shows the first ion beam bombardment aligns the alignment layer in one direction of surface 84 and the second ion beam bombardment aligns said first domain in a second direction of surface 82 for patterning alignment direction on an alignment surface from more than one direction (col. 3 lines 12-15) as Chaudhari et al. taught.

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to HOAN C. NGUYEN whose telephone number is (571)272-2296. The examiner can normally be reached on MONDAY-THURSDAY:8:00AM-4:30PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, David Nelms can be reached on (571) 272-1787. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

HOAN C. NGUYEN
Examiner
Art Unit 2871

Chn
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Examiner, Art Unit 2871